

**Search Notes****Application/Control No.**

10/769,684

**Applicant(s)/Patent under  
Reexamination**

BONILLA ET AL.

**Examiner**

Leon J. Harper

**Art Unit**

2166

**SEARCHED**

Class	Subclass	Date	Examiner
707	104.1.1, 100.10	9/7/2006	LJH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR